

Preliminary

TLP2066

FA (Factory Automation)

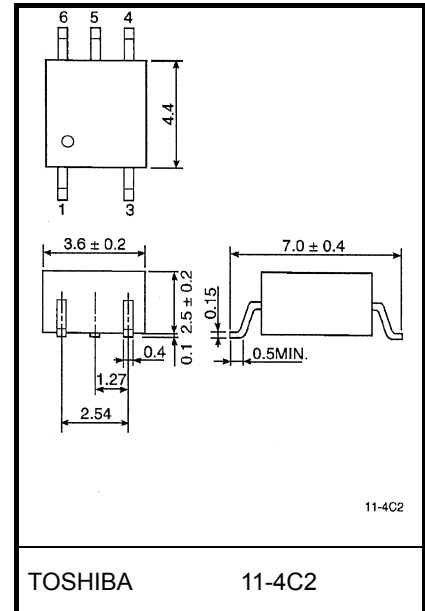
High Speed Interface

3.3V Supply Voltage

The Toshiba TLP2066 consists of a GaAlAs light-emitting diode and an integrated high-gain, high-speed photodetector. TLP2066 operates with 3.3 V supply voltage. Toshiba provides the TLP116 for supply voltage 5V type.

- Inverter logic (totempole output)
- Package type : MFSOP6
- Guaranteed performance over temperature : -40~100°C
- Power supply voltage : 3.0~3.6V
- Input thresholds current: $I_{FHL}=5\text{mA}$ (Max.)
- Propagation delay time (tpHL/tpLH): 60ns (Max.)
- Switching speed : 20MBd(TYP.)(NRZ)
- Common mode transient immunity : 15kV/us
- Isolation voltage : 3750Vrms
- UL recognition: UL1577 under application

Unit in mm

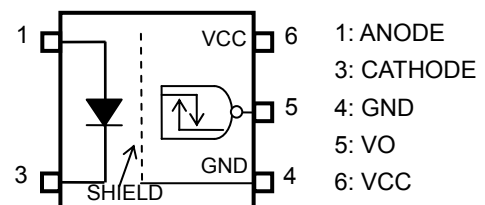


Weight: 0.09 g(Typ.)

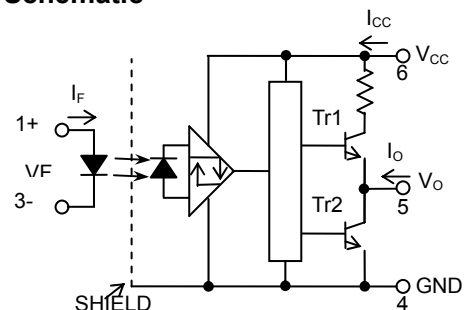
Truth Table

Input	LED	Tr1	Tr2	Output
H	ON	OFF	ON	L
L	OFF	ON	OFF	H

Pin Configuration (Top View)



Schematic



0.1uF bypass capacitor must be connected between pins 6 and 4

Absolute Maximum Ratings (Ta=25°C)

Characteristic		Symbol	Rating	Unit
LED	Forward current	I_F	25	mA
	Forward current derating (Ta≥85°C)	$\Delta I_F/\Delta T_a$	-0.7	mA/°C
	Peak transient forward current (Note1)	I_{FPT}	1	A
	Reverse voltage	V_R	6	V
DETECTOR	Output current	I_O	10	mA
	Output voltage	V_O	6	V
	Supply voltage	V_{CC}	6	V
	Output power dissipation	P_O	40	mW
Operating temperature range		T_{opr}	-40~100	°C
Storage temperature range		T_{stg}	-55~125	°C
Lead solder temperature(10s)		T_{sol}	260	°C
Isolation voltage (AC, 1min., R.H.≤60%, Ta=25°C) (Note2)		BVs	3750	Vrms

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note1: Pulse width $PW \leq 1\mu s$, 300pps.

Note2: This device is regarded as a two terminal device: pins 1 and 3 are shorted together, as are pins 4, 5 and 6.

Recommended Operating Conditions

Characteristic	Symbol	Min	Typ.	Max	Unit
Input current , ON	$I_{F(ON)}$	8	—	18	mA
Input voltage , OFF	$V_{F(OFF)}$	0	—	0.8	V
Supply voltage(*) (Note3)	V_{CC}	3.0	3.3	3.6	V

(*) This item denotes operating ranges, not meaning of recommended operating conditions.

Note: Recommended operating conditions are given as a design guideline to obtain expected performance of the device. Additionally, each item is an independent guideline respectively. In developing designs using this product, please confirm specified characteristics shown in this document.

Note3: The detector of this product requires a power supply voltage (V_{CC}) of 3.0 V higher for stable operation. If the V_{CC} is lower than this value, an ICCH may increase, or an output may be unstable. Be sure to use the product after checking the supply current, and the operation of a power-on/-off.

Note 4: A ceramic capacitor(0.1 μF) should be connected from pin 6 to pin 4 to stabilize the operation of the high gain linear amplifier. Failure to provide the bypass may impair the switching property. The total lead length between capacitor and coupler should not exceed 1 cm.

Electrical Characteristics

(Unless otherwise specified, Ta=-40~100°C, VCC=3.0~3.6 V)

Characteristic	Symbol	Test Circuit	Conditions	Min.	Typ.	Max.	Unit
Input forward voltage	V_F	—	$I_F=10\text{mA}$, $T_a=25^\circ\text{C}$	1.45	1.6	1.85	V
Temperature coefficient of forward voltage	$\Delta V_F/\Delta T_a$	—	$I_F=10\text{mA}$	—	2	—	mV/°C
Input reverse current	I_R	—	$V_R=6\text{V}$, $T_a=25^\circ\text{C}$	—	—	10	μA
Input capacitance	C_T	—	$V=0$, $f=1\text{MHz}$, $T_a=25^\circ\text{C}$	—	60	—	pF
Logic low output voltage	V_{OL}	1	$I_{OL}=1.6\text{mA}$, $I_F=12\text{mA}$	—	—	0.6	V
Logic high output voltage	V_{OH}	2	$I_{OH}=-0.02\text{mA}$, $V_F=1.05\text{V}$	2.0	—	—	V
Logic low supply current	I_{CCL}	3	$I_F=12\text{mA}$, $V_{CC}=3.3\text{V}$	—	—	5.0	mA
Logic high supply current	I_{CCH}	4	$V_F=0\text{V}$, $V_{CC}=3.3\text{V}$ (Note 3)	—	—	5.0	mA
Supply voltage	V_{CC}	—	—	3.0	—	3.6	V
Input current logic low output	I_{FHL}	—	$I_O=1.6\text{mA}$, $V_O<0.6\text{V}$	—	—	5	mA
Input voltage logic high output	V_{FLH}	—	$I_O=-0.02\text{mA}$, $V_O>2.0\text{V}$	0.8	—	—	V

*All typical values are at $T_a=25^\circ\text{C}$, $V_{CC}=3.3\text{V}$, I_F (ON) =12mA unless otherwise specified

Isolation Characteristics (Ta = 25°C)

Characteristic	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Capacitance input to output	C_S	$V_s = 0$, $f = 1\text{MHz}$ (Note 2)	—	0.8	—	pF
Isolation resistance	R_S	R.H. $\leq 60\%$, $V_S = 500\text{V}$ (Note 2)	1×10^{12}	10^{14}	—	Ω
Isolation voltage	BV_S	AC, 1 minute	3750	—	—	V_{rms}
		AC, 1 second, in oil	—	10000	—	
		DC, 1 minute, in oil	—	10000	—	Vdc

Note 4: A ceramic capacitor(0.1 μF) should be connected from pin 6 to pin 4 to stabilize the operation of the high gain linear amplifier. Failure to provide the bypass may impair the switching property.
The total lead length between capacitor and coupler should not exceed 1 cm.

Switching Characteristics

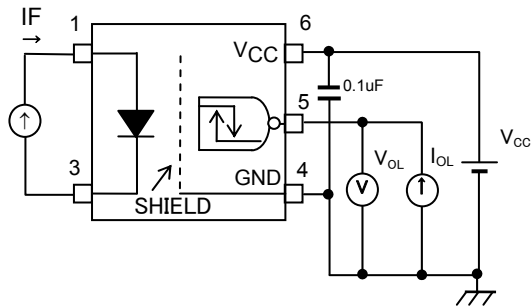
(Unless otherwise specified, $T_a = -40 \sim 100^\circ\text{C}$, $V_{CC} = 3.3\text{V}$)

Characteristic	Symbol	Test Circuit	Conditions		Min.	Typ.	Max.	Unit
Propagation delay time to logic high output	tpHL	5	IF=0→12mA	RIN=100Ω CL=15pF (Note 5)	—	—	60	ns
Propagation delay time to logic low output	tpLH		IF=12→0mA		—	—	60	ns
Propagation delay time to logic high output	tpHL	6	VIN=0→3.3V (IF=0→8mA)	RIN=220Ω CIN=47pF CL=15pF (Note 5)	—	—	60	ns
Propagation delay time to logic low output	tpLH		VIN=3.3→0V (IF=8→0mA)		—	—	60	ns
Switching time dispersion between ON and OFF	tpHL-tpLH	5	IF=12mA , RIN=100Ω , CL=15pF (Note 5)		—	—	30	ns
Output fall time (90-10%)	tf		IF=0→12mA	RIN=100Ω CL=15pF (Note 5)	—	4	—	ns
Output rise time (10-90%)	tr		IF=12→0mA		—	5	—	ns
Common mode transient immunity at high Level output	CMH	7	VCM=1000Vp-p,IF=0mA, Vo(Min)=2V,Ta=25°C		15000	—	—	V/μs
Common mode transient immunity at low level output	CM _L		VCM=1000Vp-p,IF=12mA, Vo(Max)=0.8V,Ta=25°C		-15000	—	—	V/μs

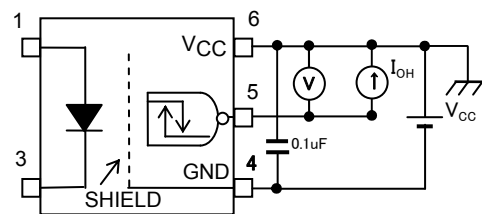
*All typical values are at $T_a = 25^\circ\text{C}$

Note 5: C_L is approximately 15pF which includes probe and jig/stray wiring capacitance.

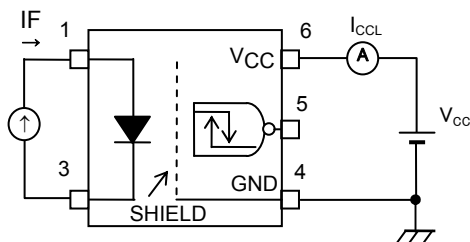
TEST CIRCUIT 1: VOL



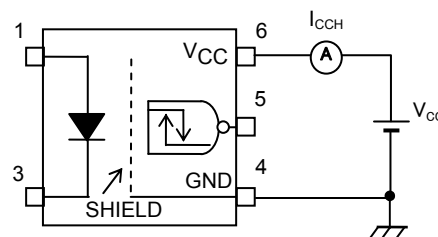
TEST CIRCUIT 2: VOH



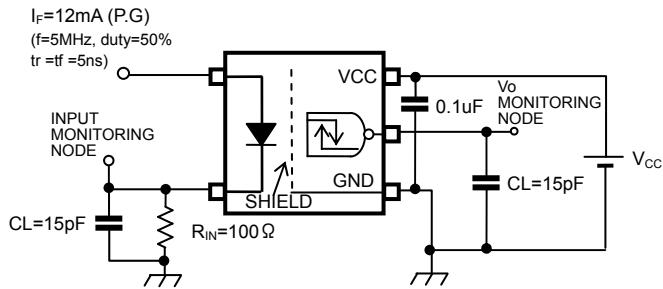
TEST CIRCUIT 3: ICCL



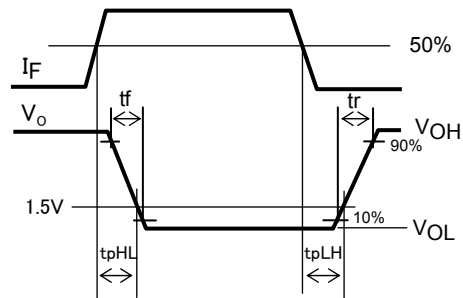
TEST CIRCUIT 4: ICCH



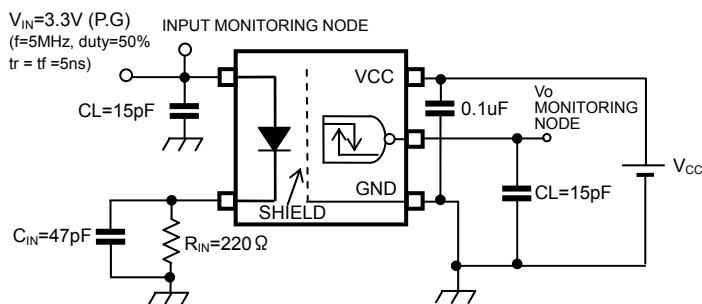
TEST CIRCUIT 5: tpHL , tpLH



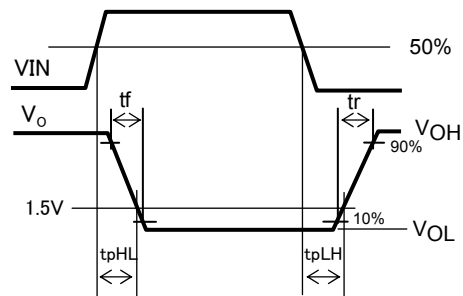
CL is capacitance of the probe and JIG.
(P.G): Pulse Generator



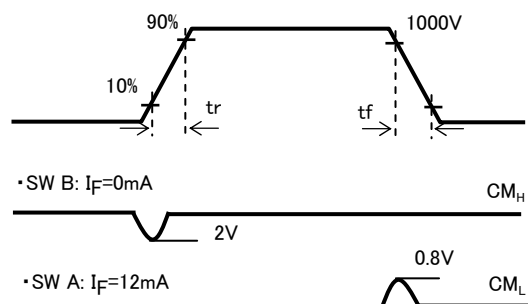
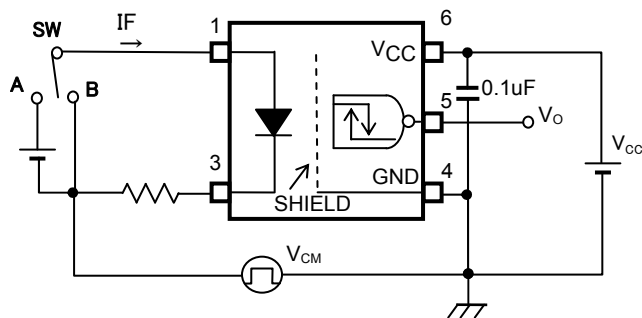
TEST CIRCUIT 6: tpHL , tpLH



CL is capacitance of the probe and JIG.
(P.G): Pulse Generator



TEST CIRCUIT 7: Common-Mode Transient Immunity Test Circuit



$$CM_H = \frac{800(V)}{t_r(\mu s)} \quad CM_L = \frac{800(V)}{t_f(\mu s)}$$

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